# 50 mA Ultra-Low Iq, Wide Input Voltage, Low Dropout Linear Voltage Regulator

The NCV8715 is 50 mA LDO Linear Voltage Regulator. It is a very stable and accurate device with ultra–low ground current consumption (4.7  $\mu$ A over the full output load range) and a wide input voltage range (up to 24 V). The regulator incorporates several protection features such as Thermal Shutdown and Current Limiting.

#### **Features**

- Operating Input Voltage Range: 2.5 V to 24 V
- Fixed Voltage Options Available: 1.2 V to 5.0 V
- Ultra Low Quiescent Current: Max. 5.8 μA Over Full Load and Temperature
- ±2% Accuracy Over Full Load, Line and Temperature Variations
- PSRR: 52 dB at 100 kHz
- Noise: 190 μV<sub>RMS</sub> from 200 Hz to 100 kHz
- Thermal Shutdown and Current Limit protection
- Available in XDFN6 1.5 x 1.5 mm and SC-70 (SC-88A) Package
- NCV Prefix for Automotive and Other Applications Requiring
  Unique Site and Control Change Requirements; AEC-Q100
  Qualified and PPAP Capable; Device Temperature Grade 1: -40°C to
  +125°C Ambient Operating Temperature Range
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

#### **Typical Applications**

- Infotainment, Audio
- Communication Systems
- Safety Systems

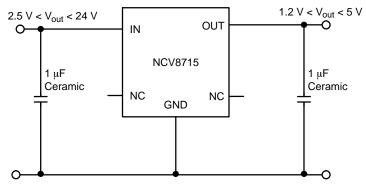


Figure 1. Typical Application Schematic



ON Semiconductor®

www.onsemi.com



XDFN6 CASE 711AE







SC-70-5 (SC-88A) CASE 419A



XXX = Specific Device Code

M = Date Code

= Pb-Free Package

(Note: Microdot may be in either location)

#### ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 19 of this data sheet.

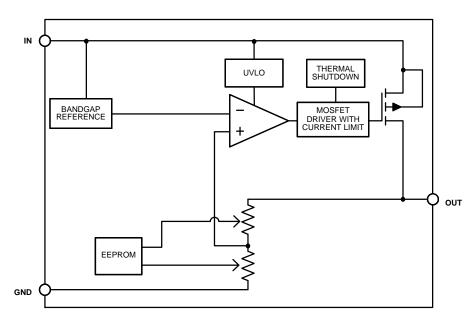


Figure 2. Simplified Block Diagram

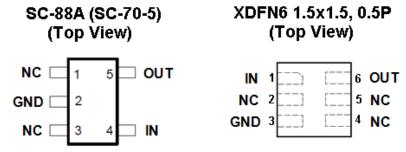


Figure 3. Pin Description

#### PIN FUNCTION DESCRIPTION

Pin	Pin No.		
SC-70	XDFN6	Pin Name	Description
5	6	OUT	Regulated output voltage pin. A small 0.47 $\mu\text{F}$ ceramic capacitor is needed from this pin to ground to assure stability.
1	2	N/C	No connection. This pin can be tied to ground to improve thermal dissipation or left disconnected.
2	3	GND	Power supply ground.
3	4	N/C	No connection. This pin can be tied to ground to improve thermal dissipation or left disconnected.
_	5	N/C	No connection. This pin can be tied to ground to improve thermal dissipation or left disconnected.
4	1	IN	Input pin. A small capacitor is needed from this pin to ground to assure stability.

#### **ABSOLUTE MAXIMUM RATINGS**

Rating	Symbol	Value	Unit
Input Voltage (Note 1)	V <sub>IN</sub>	-0.3 to 24	V
Output Voltage	V <sub>OUT</sub>	-0.3 to 6	V
Output Short Circuit Duration	t <sub>SC</sub>	Indefinite	s
Maximum Junction Temperature	$T_{J(MAX)}$	150	°C
Operating Ambient Temperature Range	T <sub>A</sub>	-40 to 125	°C
Storage Temperature Range	T <sub>STG</sub>	-55 to 150	°C
Moisture Sensitivity Level	MSL	MSL1	_
ESD Capability, Human Body Model (Note 2)	ESD <sub>HBM</sub>	2000	V
ESD Capability, Machine Model (Note 2)	ESD <sub>MM</sub>	200	V

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. Refer to ELECTRICAL CHARACTERISTICS and APPLICATION INFORMATION for Safe Operating Area.
- 2. This device series incorporates ESD protection and is tested by the following methods:
  - ESD Human Body Model tested per EIA/JESD22-A114
  - ESD Machine Model tested per EIA/JESD22-A115
  - ESD Charged Device Model tested per EIA/JESD22-C101E
  - Latch up Current Maximum Rating tested per JEDEC standard: JESD78.

#### THERMAL CHARACTERISTICS

Rating	Symbol	Value	Unit
Thermal Characteristics, SC–70 (Note 3) Thermal Resistance, Junction–to–Air (Note 4)	$R_{\theta JA}$	390	°C/W
Thermal Characteristics, XDFN6 (Note 3) Thermal Resistance, Junction–to–Air (Note 4)	$R_{ heta JA}$	260	°C/W

- 3. Refer to ELECTRICAL CHARACTERISTICS and APPLICATION INFORMATION for Safe Operating Area.
- 4. As measured using a copper heat spreading area of 650 mm<sup>2</sup>, 1 oz copper thickness.

#### **RECOMMENDED OPERATING CONDITIONS**

Parameter	Symbol	Min	Max	Unit
Input Voltage	V <sub>IN</sub>	2.5	24	V
Junction Temperature	T <sub>J</sub>	-40	125	°C

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

#### **ELECTRICAL CHARACTERISTICS – Voltage Version 1.2 V**

 $-40^{\circ}\text{C} \le \text{T}_{\text{J}} \le 125^{\circ}\text{C}; \text{V}_{\text{IN}} = 2.5 \text{ V}; \text{I}_{\text{OUT}} = 1 \text{ mA}, \text{C}_{\text{IN}} = \text{C}_{\text{OUT}} = 1.0 \,\mu\text{F}, \text{unless otherwise noted.}$  Typical values are at T<sub>J</sub> = +25°C. (Note 7)

Parameter	Test Conditions	i	Symbol	Min	Тур	Max	Unit
Operating Input Voltage	I <sub>OUT</sub> ≤ 10 mA	I <sub>OUT</sub> ≤ 10 mA		2.5		24	V
	10 mA< I <sub>OUT</sub> < 50 r	nΑ		3.0		24	
Output Voltage Accuracy	3.0 V < V <sub>IN</sub> < 24 V, 0 mA < I <sub>C</sub>	<sub>OUT</sub> < 50 mA	V <sub>OUT</sub>	1.164	1.2	1.236	V
Line Regulation	2.5 V ≤ V <sub>IN</sub> ≤ 24 V, I <sub>OUT</sub>	= 1 mA	Reg <sub>LINE</sub>		2	10	mV
Load Regulation	$I_{OUT} = 0$ mA to 50 r	nΑ	Reg <sub>LOAD</sub>		5	10	mV
Dropout Voltage (Note 5)			$V_{DO}$			_	mV
Maximum Output Current	t Current (Note 8)		I <sub>OUT</sub>	100		200	mA
	0 < I <sub>OUT</sub> < 50 mA, V <sub>IN</sub> :	= 24 V	I <sub>GND</sub>		3.4	5.8	
Power Supply Rejection Ratio	$\begin{split} V_{\text{IN}} = 3.0 \text{ V}, V_{OUT} = 1.2 \text{ V} \\ V_{PP} = 200 \text{ mV modulation} \\ I_{OUT} = 1 \text{ mA, } C_{OUT} = 10 \mu\text{F} \end{split}$	f = 100 kHz	PSRR		60		dB
Output Noise Voltage		V <sub>OUT</sub> = 1.2 V, I <sub>OUT</sub> = 50 mA f = 200 Hz to 100 kHz, C <sub>OUT</sub> = 10 μF			65		$\mu V_{rms}$
Thermal Shutdown Temperature (Note 6)	Temperature increasing from $T_J = +25^{\circ}C$		T <sub>SD</sub>		170		°C
Thermal Shutdown Hysteresis (Note 6)	Temperature falling from	m T <sub>SD</sub>	T <sub>SDH</sub>	_	15	_	°C

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Not Characterized at V<sub>IN</sub> = 3.0 V, V<sub>OUT</sub> = 1.2 V, I<sub>OUT</sub> = 50 mA.

6. Guaranteed by design and characterization.

- Performance guaranteed over the indicated operating temperature range by design and/or characterization production tested at T<sub>J</sub> = T<sub>A</sub> = 25°C. Low duty cycle pulse techniques are used during testing to maintain the junction temperature as close to ambient as possible.
- 8. Respect SOA.

# **ELECTRICAL CHARACTERISTICS – Voltage Version 1.5 V**

 $-40^{\circ}C \le T_{J} \le 125^{\circ}C$ ;  $V_{IN} = 2.5 \text{ V}$ ;  $I_{OUT} = 1 \text{ mA}$ ,  $C_{IN} = C_{OUT} = 1.0 \ \mu\text{F}$ , unless otherwise noted. Typical values are at  $T_{J} = +25^{\circ}C$ . (Note 11)

Parameter	Test Conditions		Symbol	Min	Тур	Max	Unit
Operating Input Voltage	I <sub>OUT</sub> ≤ 10 mA		V <sub>IN</sub>	2.5		24	V
	10 mA < I <sub>OUT</sub> < 50 m	ıΑ		3.0		24	1
Output Voltage Accuracy	3.0 V < VIN < 24 V, 0 < I <sub>OUT</sub>	< 50 mA	V <sub>OUT</sub>	1.455	1.5	1.545	V
Line Regulation	Vout + 1 V ≤ Vin ≤ 24 V, I <sub>OU</sub>	<sub>T</sub> = 1 mA	Reg <sub>LINE</sub>		2	10	mV
Load Regulation	I <sub>OUT</sub> = 0 mA to 50 m.	A	Reg <sub>LOAD</sub>		5	10	mV
Dropout Voltage (Note 9)			$V_{DO}$			_	mV
Maximum Output Current	(Note 12)	(Note 12)		100		200	mA
Ground Current	0 < I <sub>OUT</sub> < 50 mA, V <sub>IN</sub> =	24 V	I <sub>GND</sub>		3.4	5.8	μΑ
Power Supply Rejection Ratio	$\begin{aligned} &V_{IN} = 3.0 \text{ V}, V_{OUT} = 1.5 \text{ V} \\ &V_{PP} = 200 \text{ mV modulation} \\ &I_{OUT} = 1 \text{ mA, } C_{OUT} = 10 \mu\text{F} \end{aligned}$	f = 100 kHz	PSRR		56		dB
Output Noise Voltage	V <sub>OUT</sub> = 1.5 V, I <sub>OUT</sub> = 50 f = 200 Hz to 100 kHz, C <sub>OUT</sub>	) mA <sub>Γ</sub> = 10 μF	$V_N$		75		$\mu V_{rms}$
Thermal Shutdown Temperature (Note 10)	Temperature increasing from T <sub>J</sub> = +25°C		T <sub>SD</sub>		170		°C
Thermal Shutdown Hysteresis (Note 10)	Temperature falling from	ı T <sub>SD</sub>	T <sub>SDH</sub>	_	15	_	°C

<sup>9.</sup> Not Characterized at  $V_{IN}$  = 3.0 V,  $V_{OUT}$  = 1.5 V,  $I_{OUT}$  = 50 mA. 10. Guaranteed by design and characterization.

<sup>11.</sup> Performance guaranteed over the indicated operating temperature range by design and/or characterization production tested at T<sub>J</sub> = T<sub>A</sub> = 25°C. Low duty cycle pulse techniques are used during testing to maintain the junction temperature as close to ambient as possible. 12. Respect SOA.

### **ELECTRICAL CHARACTERISTICS – Voltage Version 1.8 V**

 $-40^{\circ}C \le T_{J} \le 125^{\circ}C$ ;  $V_{IN} = 2.8V$ ;  $I_{OUT} = 1$  mA,  $C_{IN} = C_{OUT} = 1.0$   $\mu F$ , unless otherwise noted. Typical values are at  $T_{J} = +25^{\circ}C$ . (Note 15)

Parameter	Test Conditions		Symbol	Min	Тур	Max	Unit
Operating Input Voltage	Iou⊤ ≤10 mA		V <sub>IN</sub>	2.8		24	V
	10 mA < I <sub>OUT</sub> < 50 m	nΑ		3.0		24	1
Output Voltage Accuracy	3.0 V < V <sub>IN</sub> < 24 V, 0 < I <sub>OUT</sub>	3.0 V < V <sub>IN</sub> < 24 V, 0 < I <sub>OUT</sub> < 10 mA		1.746	1.8	1.854	V
Line Regulation	3 V ≤ VIN ≤ 24 V, I <sub>OUT</sub> =	1 mA	Reg <sub>LINE</sub>		2	10	mV
Load Regulation	$I_{OUT} = 0$ mA to 50 m	ıA	Reg <sub>LOAD</sub>		5	10	mV
Dropout Voltage (Note 13)			V <sub>DO</sub>				mV
Maximum Output Current	(Note 16)	(Note 16)		100		200	mA
Ground Current	0 < I <sub>OUT</sub> < 50 mA, V <sub>IN</sub> =	: 24 V	I <sub>GND</sub>		3.4	5.8	μΑ
Power Supply Rejection Ratio	$\begin{split} &V_{IN}=3.0 \text{ V, } V_{OUT}=1.8 \text{ V} \\ &V_{PP}=200 \text{ mV modulation} \\ &I_{OUT}=1 \text{ mA, } C_{OUT}=10  \mu F \end{split}$	f = 100 kHz	PSRR		60		dB
Output Noise Voltage	Vout = 1.8 V, lout = 50 f = 200 Hz to 100 kHz, C <sub>OU</sub>		V <sub>N</sub>		95		$\mu V_{rms}$
Thermal Shutdown Temperature (Note 14)	Temperature increasing from T <sub>J</sub> = +25°C		T <sub>SD</sub>		170		°C
Thermal Shutdown Hysteresis (Note 14)	Temperature falling from	n T <sub>SD</sub>	T <sub>SDH</sub>	_	15	_	°C

 <sup>13.</sup> Not characterized at V<sub>IN</sub> = 3.0 V, V<sub>OUT</sub> = 1.8 V, I<sub>OUT</sub> = 50 mA
 14. Guaranteed by design and characterization.
 15. Performance guaranteed over the indicated operating temperature range by design and/or characterization production tested at T<sub>J</sub> = T<sub>A</sub> = 25°C. Low duty cycle pulse techniques are used during testing to maintain the junction temperature as close to ambient as possible.

<sup>16.</sup> Respect SOA.

#### **ELECTRICAL CHARACTERISTICS – Voltage Version 2.1 V**

 $-40^{\circ}C \le T_{J} \le 125^{\circ}C$ ;  $V_{IN} = 3.1V$ ;  $I_{OUT} = 1$  mA,  $C_{IN} = C_{OUT} = 1.0$   $\mu F$ , unless otherwise noted. Typical values are at  $T_{J} = +25^{\circ}C$ . (Note 19)

Parameter	Test Conditions		Symbol	Min	Тур	Max	Unit
Operating Input Voltage	0 < I <sub>OUT</sub> < 50 mA		V <sub>IN</sub>	3.1		24	V
Output Voltage Accuracy	3.1 V < V <sub>IN</sub> < 24 V, 0 < I <sub>OUT</sub>	< 50 mA	V <sub>OUT</sub>	2.058	2.1	2.142	V
Line Regulation	3.1 V ≤ VIN ≤ 24 V, I <sub>OUT</sub> =	3.1 V ≤ VIN ≤ 24 V, I <sub>OUT</sub> = 1 mA			3	45	mV
	3.3 V ≤ VIN ≤ 24 V, I <sub>OUT</sub> =	: 1 mA			3	10	1
Load Regulation	I <sub>OUT</sub> = 0 mA to 50 m/	A	Reg <sub>LOAD</sub>		10	15	mV
Dropout Voltage (Note 17)			$V_{DO}$				mV
Maximum Output Current	(Note 20)	(Note 20)		100		200	mA
Ground Current	0 < I <sub>OUT</sub> < 50 mA, V <sub>IN</sub> =	24 V	I <sub>GND</sub>		3.4	5.8	μΑ
Power Supply Rejection Ratio	$\begin{aligned} &V_{IN}=3.1 \text{ V, } V_{OUT}=2.1 \text{ V} \\ &V_{PP}=200 \text{ mV modulation} \\ &I_{OUT}=1 \text{ mA, } C_{OUT}=10 \mu\text{F} \end{aligned}$	f = 100 kHz	PSRR		60		dB
Output Noise Voltage	Vout = 2.1 V, Iout = 50 f = 200 Hz to 100 kHz, C <sub>OUT</sub>		V <sub>N</sub>		105		$\mu V_{rms}$
Thermal Shutdown Temperature (Note 18)	Temperature increasing from T <sub>J</sub> = +25°C		T <sub>SD</sub>		170		°C
Thermal Shutdown Hysteresis (Note 18)	Temperature falling from	T <sub>SD</sub>	T <sub>SDH</sub>	_	15	_	°C

<sup>17.</sup> Not characterized at V<sub>IN</sub> = 3.1 V, V<sub>OUT</sub> = 2.1 V, I<sub>OUT</sub> = 50 mA

18. Guaranteed by design and characterization.

19. Performance guaranteed over the indicated operating temperature range by design and/or characterization production tested at T<sub>J</sub> = T<sub>A</sub> = 25°C. Low duty cycle pulse techniques are used during testing to maintain the junction temperature as close to ambient as possible.

<sup>20.</sup> Respect SOA.

#### **ELECTRICAL CHARACTERISTICS – Voltage Version 2.5 V**

 $-40^{\circ}C \le T_{J} \le 125^{\circ}C$ ;  $V_{IN} = 3.5 \text{ V}$ ;  $I_{OUT} = 1 \text{ mA}$ ,  $C_{IN} = C_{OUT} = 1.0 \ \mu\text{F}$ , unless otherwise noted. Typical values are at  $T_{J} = +25^{\circ}C$ . (Note 23)

Parameter	Test Conditions		Symbol	Min	Тур	Max	Unit
Operating Input Voltage	0 < I <sub>OUT</sub> < 50 mA	0 < I <sub>OUT</sub> < 50 mA		3.5		24	V
Output Voltage Accuracy	3.5 V < V <sub>IN</sub> < 24 V, 0 < I <sub>OU</sub>	<sub>T</sub> < 50 mA	V <sub>OUT</sub>	2.45	2.5	2.55	V
Line Regulation	V <sub>OUT</sub> + 1 V ≤ V <sub>IN</sub> ≤ 24 V, I <sub>O</sub>	<sub>OUT</sub> = 1 mA	Reg <sub>LINE</sub>		3	10	mV
Load Regulation	$I_{OUT} = 0$ mA to 50 r	nA	Reg <sub>LOAD</sub>		10	15	mV
Dropout Voltage (Note 21)	$V_{DO} = V_{IN} - (V_{OUT(NOM)} - I_{OUT} = 50 \text{ mA}$	$V_{DO} = V_{IN} - (V_{OUT(NOM)} - 125 \text{ mV})$ $I_{OUT} = 50 \text{ mA}$			260	450	mV
Maximum Output Current	(Note 24)	(Note 24)		100		200	mA
Ground Current	0 < I <sub>OUT</sub> < 50 mA, Vin =	= 24 V	I <sub>GND</sub>		3.4	5.8	μΑ
Power Supply Rejection Ratio	$\begin{array}{c} \text{VIN} = 3.5 \text{ V, V}_{OUT} = 2.5 \text{ V} \\ \text{VPP} = 200 \text{ mV modulation} \\ \text{I}_{OUT} = 1 \text{ mA, C}_{OUT} = 10 \mu\text{F} \end{array}$	f = 100 kHz	PSRR		60		dB
Output Noise Voltage	V <sub>OUT</sub> = 2.5 V, I <sub>OUT</sub> = 5 f = 200 Hz to 100 kHz, C <sub>OU</sub>	50 mA <sub>JT</sub> = 10 μF	V <sub>N</sub>		115		$\mu V_{rms}$
Thermal Shutdown Temperature (Note 22)	Temperature increasing from	Temperature increasing from T <sub>J</sub> = +25°C			170		°C
Thermal Shutdown Hysteresis (Note 22)	Temperature falling from	m T <sub>SD</sub>	T <sub>SDH</sub>	_	15	_	°C

<sup>21.</sup> Characterized when V<sub>OUT</sub> falls 125 mV below the regulated voltage and only for devices with V<sub>OUT</sub> = 2.5 V.
22. Guaranteed by design and characterization.
23. Performance guaranteed over the indicated operating temperature range by design and/or characterization production tested at
T<sub>J</sub> = T<sub>A</sub> = 25°C. Low duty cycle pulse techniques are used during testing to maintain the junction temperature as close to ambient as possible.
24. Respect SOA.

#### **ELECTRICAL CHARACTERISTICS - Voltage Version 3.0 V**

 $-40^{\circ}C \le T_{J} \le 125^{\circ}C$ ;  $V_{IN} = 4.0 \text{ V}$ ;  $I_{OUT} = 1 \text{ mA}$ ,  $C_{IN} = C_{OUT} = 1.0 \ \mu\text{F}$ , unless otherwise noted. Typical values are at  $T_{J} = +25^{\circ}C$ . (Note 27)

Parameter	Test Conditions		Symbol	Min	Тур	Max	Unit
Operating Input Voltage	0 < I <sub>OUT</sub> < 50 mA		Vin	4.0		24	V
Output Voltage Accuracy	4.0 V < V <sub>IN</sub> < 24 V, 0< I <sub>OU7</sub>	<sub>r</sub> < 50 mA	Vout	2.94	3.0	3.06	V
Line Regulation	V <sub>OUT</sub> + 1 V ≤ V <sub>IN</sub> ≤ 24 V, I <sub>O</sub>	<sub>UT</sub> = 1 mA	Reg <sub>LINE</sub>		3	10	mV
Load Regulation	I <sub>OUT</sub> = 0 mA to 50 n	nA	Reg <sub>LOAD</sub>		10	15	mV
Dropout voltage (Note 25)	$V_{DO} = V_{IN} - (V_{OUT(NOM)} - I_{OUT} = 50 \text{ mA}$	$V_{DO} = V_{IN} - (V_{OUT(NOM)} - 150 \text{ mV})$ $I_{OUT} = 50 \text{ mA}$			250	400	mV
Maximum Output Current	(Note 28)	(Note 28)		100		200	mA
Ground current	0 < IOUT < 50 mA, VIN =	= 24 V	IGND		3.4	5.8	μΑ
Power Supply Rejection Ratio	$\begin{aligned} &V_{IN} = 4.0 \text{ V}, V_{OUT} = 3.0 \text{ V} \\ &V_{PP} = 100 \text{ mV modulation} \\ &I_{OUT} = 1 \text{ mA}, C_{OUT} = 10 \mu\text{F} \end{aligned}$	f = 100 kHz	PSRR		60		dB
Output Noise Voltage	V <sub>OUT</sub> = 3 V, I <sub>OUT</sub> = 50 f = 200 Hz to 100 kHz, C <sub>OU</sub>		Vn		135		$\mu V_{rms}$
Thermal Shutdown Temperature (Note 26)	Temperature increasing from T <sub>J</sub> = +25°C		Tsp		170		°C
Thermal Shutdown Hysteresis (Note 26)	Temperature falling from	m T <sub>SD</sub>	TsdH	-	25	-	°C

<sup>25.</sup> Characterized when VouT falls 150 mV below the regulated voltage and only for devices with VouT = 3.0 V

<sup>26.</sup> Guaranteed by design and characterization.

<sup>27.</sup> Performance guaranteed over the indicated operating temperature range by design and/or characterization production tested at  $T_J = T_A = 25$ °C. Low duty cycle pulse techniques are used during testing to maintain the junction temperature as close to ambient as possible.

<sup>28.</sup> Respect SOA

#### **ELECTRICAL CHARACTERISTICS - Voltage Version 3.3 V**

 $-40^{\circ}C \le T_{J} \le 125^{\circ}C$ ;  $V_{IN} = 4.3 \text{ V}$ ;  $I_{OUT} = 1 \text{ mA}$ ,  $C_{IN} = C_{OUT} = 1.0 \ \mu\text{F}$ , unless otherwise noted. Typical values are at  $T_{J} = +25^{\circ}C$ . (Note 31)

Parameter	Test Conditions		Symbol	Min	Тур	Max	Unit
Operating Input Voltage	0 < I <sub>OUT</sub> < 50 mA	0 < I <sub>OUT</sub> < 50 mA		4.3		24	V
Output Voltage Accuracy	4.3 V < V <sub>IN</sub> < 24 V, 0 < I <sub>OU</sub>	<sub>T</sub> < 50 mA	V <sub>OUT</sub>	3.234	3.3	3.366	V
Line Regulation	$V_{OUT}$ + 1 V $\leq$ VIN $\leq$ 24 V, $I_{O}$	<sub>UT</sub> = 1 mA	Reg <sub>LINE</sub>		3	10	mV
Load Regulation	$I_{OUT} = 0$ mA to 50 r	nA	Reg <sub>LOAD</sub>		10	15	mV
Dropout Voltage (Note 29)	VDO = VIN - (VOUT(NOM) - IOUT = 50 mA	VDO = VIN - (VOUT(NOM) - 165 mV)			230	350	mV
Maximum Output Current	(Note 32)	(Note 32)		100		200	mA
Ground Current	0 < IOUT < 50 mA, VIN =	= 24 V	I <sub>GND</sub>		3.4	5.8	μΑ
Power Supply Rejection Ratio	$\begin{aligned} &V_{IN} = 4.3 \text{ V, } V_{OUT} = 3.3 \text{ V} \\ &V_{PP} = 200 \text{ mV modulation} \\ &I_{OUT} = 1 \text{ mA, } C_{OUT} = 10  \mu\text{F} \end{aligned}$	f = 100 kHz	PSRR		60		dB
Output Noise Voltage	Vout = 4.3 V, lout = 5 f = 200 Hz to 100 kHz, C <sub>OL</sub>		V <sub>N</sub>		140		$\mu V_{rms}$
Thermal Shutdown Temperature (Note 30)	Temperature increasing from T <sub>J</sub> = +25°C		T <sub>SD</sub>		170		°C
Thermal Shutdown Hysteresis (Note 30)	Temperature falling from	m T <sub>SD</sub>	T <sub>SDH</sub>	_	15	_	°C

<sup>29.</sup> Characterized when Vout falls 165 mV below the regulated voltage and only for devices with Vout = 3.3 V.

<sup>30.</sup> Guaranteed by design and characterization.

<sup>31.</sup> Performance guaranteed over the indicated operating temperature range by design and/or characterization production tested at T<sub>J</sub> = T<sub>A</sub> = 25°C. Low duty cycle pulse techniques are used during testing to maintain the junction temperature as close to ambient as possible. 32. Respect SOA.

#### **ELECTRICAL CHARACTERISTICS – Voltage Version 5.0 V**

 $-40^{\circ}C \le T_{J} \le 125^{\circ}C$ ;  $V_{IN} = 6.0 \text{ V}$ ;  $I_{OUT} = 1 \text{ mA}$ ,  $C_{IN} = C_{OUT} = 1 \mu\text{F}$ , unless otherwise noted. Typical values are at  $T_{J} = +25^{\circ}C$ . (Note 35)

Parameter	Test Conditions		Symbol	Min	Тур	Max	Unit
Operating Input Voltage	0 < IOUT < 50 mA	0 < IOUT < 50 mA		6.0		24	V
Output Voltage Accuracy	6.0V < VIN < 24V, 0< IOUT	< 50 mA	V <sub>OUT</sub>	4.9	5.0	5.1	V
Line Regulation	Vout + 1 V ≤ Vin ≤ 24 V, Io	ut = 1mA	Reg <sub>LINE</sub>		3	10	mV
Load Regulation	IOUT = 0 mA to 50 m	nΑ	Reg <sub>LOAD</sub>		10	15	mV
Dropout Voltage (Note 33)	VDO = VIN - (VOUT(NOM) - 2 IOUT = 50 mA	VDO = VIN - (VOUT(NOM) - 250 mV) IOUT = 50 mA			230	350	mV
Maximum Output Current	(Note 36)	(Note 36)		90		200	mA
Ground Current	0 < IOUT < 50 mA, VIN =	: 24 V	I <sub>GND</sub>		3.4	5.8	μΑ
Power Supply Rejection Ratio	$\begin{array}{c} \text{Vin} = 6.0 \text{ V, Vout} = 5.0 \text{ V} \\ \text{Vpp} = 200 \text{ mV modulation} \\ \text{Iout} = 1 \text{ mA, C}_{OUT} = 10 \mu\text{F} \end{array}$	f = 100 kHz	PSRR		56		dB
Output Noise Voltage	Vout = 5.0 V, Iout = 50 f = 200 Hz to 100 kHz, C <sub>OU</sub>		V <sub>N</sub>		190		$\mu V_{rms}$
Thermal Shutdown Temperature (Note 34)	Temperature increasing from	Temperature increasing from T <sub>J</sub> = +25°C			170		°C
Thermal Shutdown Hysteresis (Note 34)	Temperature falling fron	n T <sub>SD</sub>	T <sub>SDH</sub>	-	15	_	°C

<sup>33.</sup> Characterized when Vout falls 250 mV below the regulated voltage and only for devices with Vout = 5.0 V.

<sup>34.</sup> Guaranteed by design and characterization.

<sup>35.</sup> Performance guaranteed over the indicated operating temperature range by design and/or characterization production tested at T<sub>J</sub> = T<sub>A</sub> = 25°C. Low duty cycle pulse techniques are used during testing to maintain the junction temperature as close to ambient as possible. 36. Respect SOA.

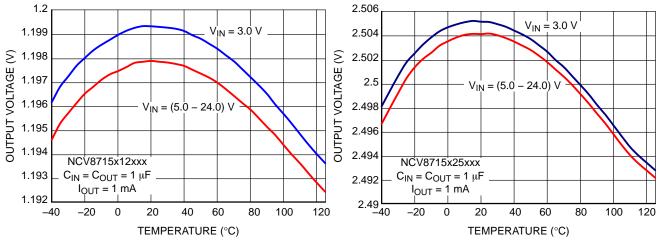


Figure 4. Output Voltage vs. Temperature

Figure 5. Output Voltage vs. Temperature

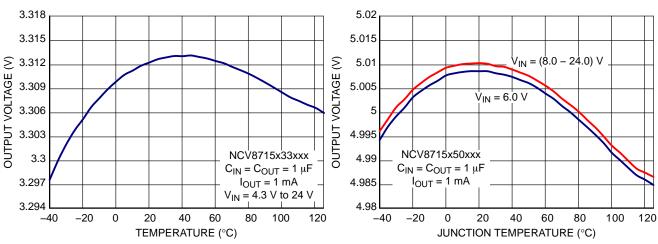


Figure 6. Output Voltage vs. Temperature

Figure 7. Output Voltage vs. Temperature

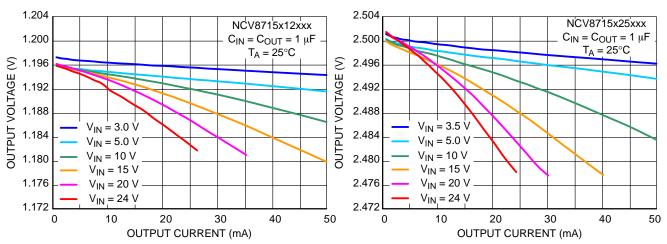


Figure 8. Output Voltage vs. Output Current

Figure 9. Output Voltage vs. Output Current

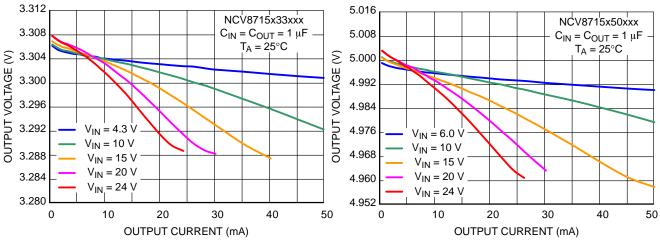


Figure 10. Output Voltage vs. Output Current

Figure 11. Output Voltage vs. Output Current

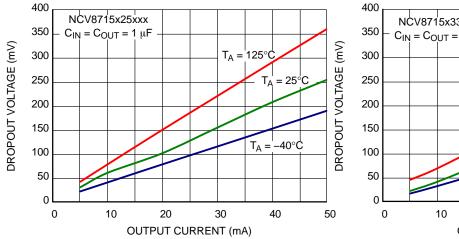


Figure 12. Dropout Voltage vs. Output Current

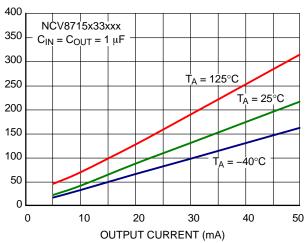


Figure 13. Dropout Voltage vs. Output Current

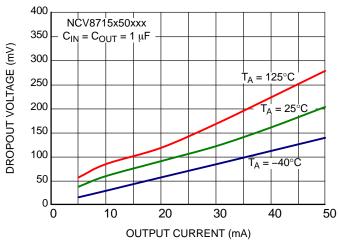


Figure 14. Dropout Voltage vs. Output Current

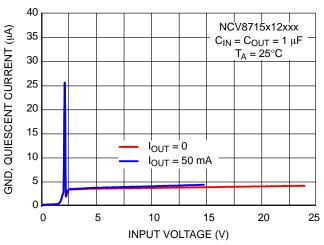


Figure 15. Ground Current vs. Input Voltage

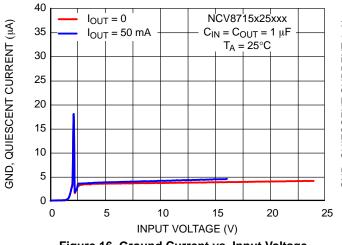


Figure 16. Ground Current vs. Input Voltage

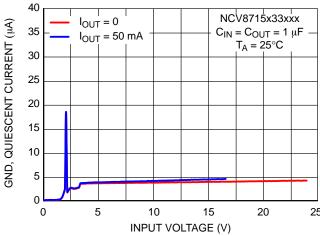


Figure 17. Ground Current vs. Input Voltage

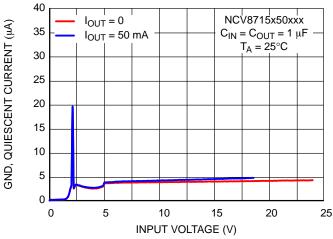


Figure 18. Ground Current vs. Input Voltage

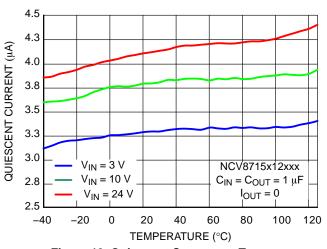


Figure 19. Quiescent Current vs. Temperature

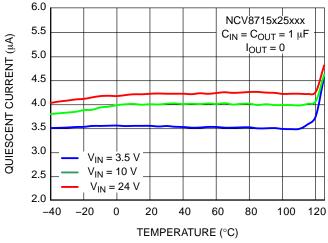


Figure 20. Quiescent Current vs. Temperature

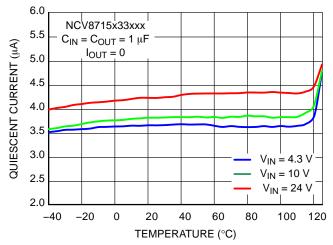


Figure 21. Quiescent Current vs. Temperature

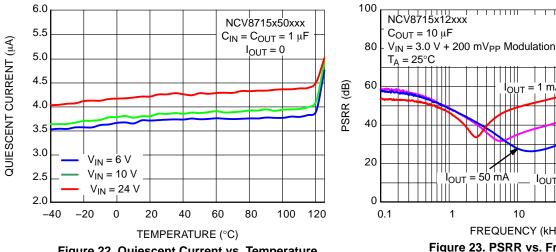
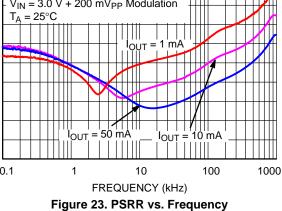


Figure 22. Quiescent Current vs. Temperature



1000

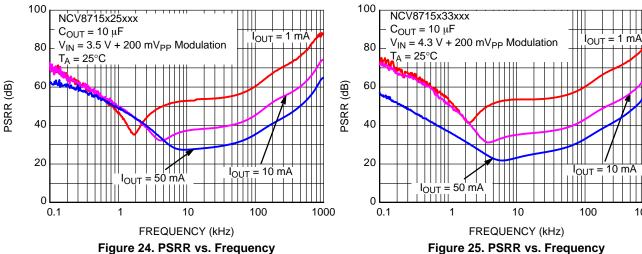


Figure 24. PSRR vs. Frequency

100

80

60

40

20

0 0.1

PSRR (dB)

NCV8715x50xxx

 $V_{IN} = 6.0 \text{ V} + 200 \text{ mV}_{PP} \text{ Modulation}$ 

 $C_{OUT} = 10 \mu F$ 

T<sub>A</sub> = 25°C

1.6  $C_{OUT} = 10 \mu F$ , 65.1  $\mu Vrms @ 200 Hz - 100 kHz$ OUTPUT VOLTAGE NOISE (μV/√Hz)  $C_{OUT}$  = 4.7  $\mu$ F, 80.5  $\mu$ Vrms @ 200 Hz – 100 kHz 1.4  $C_{OUT}$  = 2.2  $\mu$ F, 111.5  $\mu$ Vrms @ 200 Hz - 100 kHz 1.2  $C_{OUT} = 1.0 \mu F$ , 172.1  $\mu Vrms @ 200 Hz - 100 kHz$ 1.0 0.8 0.6 0.4 /8715x12xx  $I_{OUT} = 50 \text{ mA}$ 0.2 T<sub>A</sub> = 25°C  $V_{IN} = 3 V$ 0.0 0.01 0.1 10 1000 100 FREQUENCY (kHz)

FREQUENCY (kHz) Figure 26. PSRR vs. Frequency

10

I<sub>OUT</sub> = 50 mA

Figure 27. Output Spectral Noise Density vs. Frequency

1000

= 10 mA

100

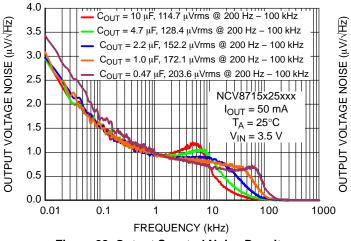


Figure 28. Output Spectral Noise Density vs. Frequency

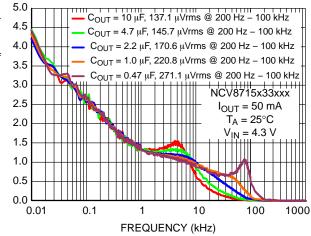


Figure 29. Output Spectral Noise Density vs. Frequency

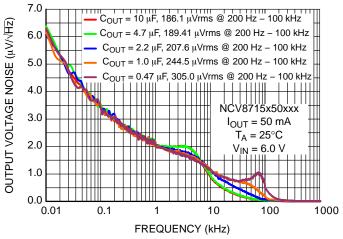


Figure 30. Output Spectral Noise Density vs. Frequency

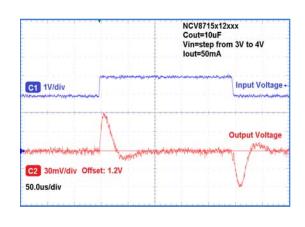


Figure 31. Line Transient Response

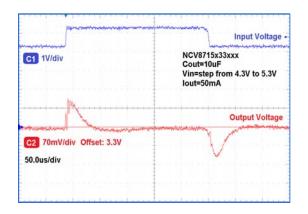


Figure 32. Line Transient Response

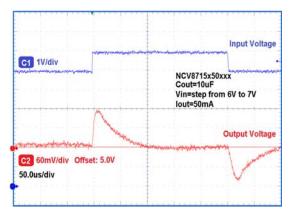


Figure 33. Line Transient Response

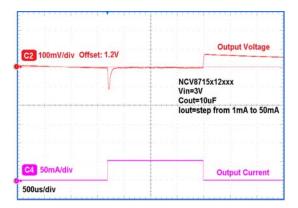
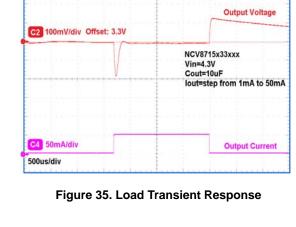


Figure 34. Load Transient Response



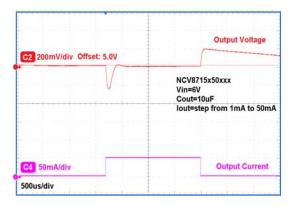


Figure 36. Load Transient Response

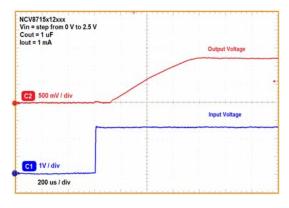


Figure 37. Input Voltage Turn-On Response

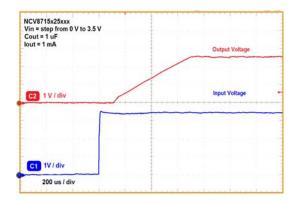


Figure 38. Input Voltage Turn-On Response

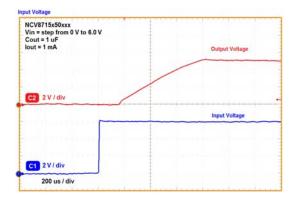


Figure 39. Input Voltage Turn-On Response

#### APPLICATIONS INFORMATION

The NCV8715 is the member of new family of Wide Input Voltage Range Low Dropout Regulators which delivers Ultra Low Ground Current consumption, Good Noise and Power Supply Rejection Ratio Performance.

#### Input Decoupling (C<sub>IN</sub>)

It is recommended to connect at least  $0.1~\mu F$  Ceramic X5R or X7R capacitor between IN and GND pin of the device. This capacitor will provide a low impedance path for any unwanted AC signals or Noise superimposed onto constant Input Voltage. The good input capacitor will limit the influence of input trace inductances and source resistance during sudden load current changes.

Higher capacitance and lower ESR Capacitors will improve the overall line transient response.

#### Output Decoupling (COUT)

The NCV8715 does not require a minimum Equivalent Series Resistance (ESR) for the output capacitor. The device is designed to be stable with standard ceramics capacitors with values of 0.47  $\mu F$  or greater up to 10  $\mu F$ . The X5R and X7R types have the lowest capacitance variations over temperature thus they are recommended.

#### Power Dissipation and Heat sinking

The maximum power dissipation supported by the device is dependent upon board design and layout. Mounting pad configuration on the PCB, the board material, and the ambient temperature affect the rate of junction temperature rise for the part. The maximum power dissipation the NCV8715 can handle is given by:

$$P_{D(MAX)} = \frac{\left[T_{J(MAX)} - T_{A}\right]}{R_{\theta JA}}$$
 (eq. 1)

The power dissipated by the NCV8715 for given application conditions can be calculated from the following equations:

$$P_D \approx V_{IN} (I_{GND} (I_{OUT})) + I_{OUT} (V_{IN} - V_{OUT})$$
 (eq. 2)

or

$$V_{IN(MAX)} \approx \frac{P_{D(MAX)} + (V_{OUT} \times I_{OUT})}{I_{OUT} + I_{GND}}$$
 (eq. 3)

For reliable operation, junction temperature should be limited to +125°C maximum.

#### **Hints**

VIN and GND printed circuit board traces should be as wide as possible. When the impedance of these traces is high, there is a chance to pick up noise or cause the regulator to malfunction. Place external components, especially the output capacitor, as close as possible to the NCV8715, and make traces as short as possible.

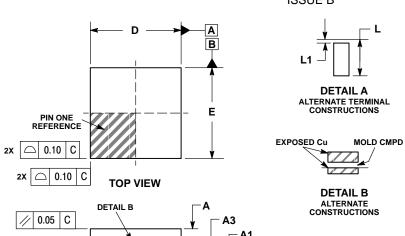
#### **ORDERING INFORMATION**

Device	Nominal Output Voltage	Marking	Package	Shipping <sup>†</sup>
NCV8715SQ12T2G	1.2 V	V5A	SC-88A/SC-70 (Pb-Free)* 3000 / Tape & R	
NCV8715SQ15T2G	1.5 V	V5C		
NCV8715SQ18T2G	1.8 V	V5D		
NCV8715SQ21T2G	2.1 V	V5J		
NCV8715SQ25T2G	2.5 V	V5E		
NCV8715SQ30T2G	3.0 V	V5F		3000 / Tape & Reel
NCV8715SQ33T2G	3.3 V	V5G		
NCV8715SQ50T2G	5.0 V	V5H		
NCV8715MX12TBG	1.2 V	VA	XDFN6 (Pb-Free)*	
NCV8715MX15TBG	1.5 V	VC		
NCV8715MX18TBG	1.8 V	VE		
NCV8715MX25TBG	2.5 V	VE		
NCV8715MX30TBG	3.0 V	VF		
NCV8715MX33TBG	3.3 V	VG		
NCV8715MX50TBG	5.0 V	VH		

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.
\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### **PACKAGE DIMENSIONS**

#### XDFN6 1.5x1.5, 0.5P CASE 711AE **ISSUE B**



е

- 6x b

SEATING PLANE

0.10 C A B

С 0.05

NOTE 3

L2

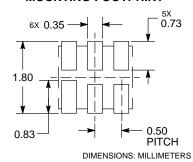
**SIDE VIEW** 

**BOTTOM VIEW** 

- NOTES:
  1. DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: MILLIMETERS.
- 3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.10 AND 0.20mm FROM TERMINAL TIP.

	MILLIMETERS			
DIM	MIN	MAX		
Α	0.35	0.45		
A1	0.00	0.05		
A3	0.13 REF			
b	0.20	0.30		
D	1.50 BSC			
E	1.50 BSC			
е	0.50 BSC			
L	0.40	0.60		
L1		0.15		
L2	0.50	0.70		

#### **RECOMMENDED MOUNTING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering

details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### PACKAGE DIMENSIONS

# SC-88A (SC-70-5/SOT-353)

CASE 419A-02 **ISSUE L** 

NOTES:

DIM

D 0.004

G

A 0.071

0.045

0.031

NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.

2. CONTROLLING DIMENSION: INCH.

3. 419A-01 OBSOLETE. NEW STANDARD

INCHES MIN MAX

0.026 BSC

0.004 0.010

0.004 0.012

0.008 REF 0.079 0.087

0.087

0.053

0.043

0.012

0.004

419A-02.
DIMENSIONS A AND B DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

MILLIMETERS

MIN MAX

0.65 BSC

0.10 0.30 0.20 REF

2.20

1.35

0.30

0.10

0.25

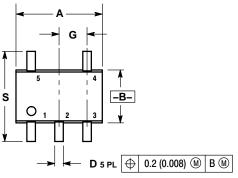
1.80

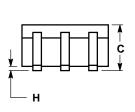
1.15

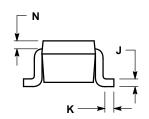
0.80

0.10

0.10







#### **SOLDER FOOTPRINT\***

# 0.50 0.0197 0.65 0.025 0.65 0.025 0.40 0.0157 1.9 0.0748 mm **SCALE 20:1**

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ON Semiconductor and III) are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <a href="https://www.onsemi.com/site/pdf/Patent-Marking.pdf">www.onsemi.com/site/pdf/Patent-Marking.pdf</a>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that ON Semiconductor was negligent regarding the design or manufacture of the part. ON Semiconductor is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

#### **PUBLICATION ORDERING INFORMATION**

#### LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free

Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910

Japan Customer Focus Center

Phone: 81–3–5817–1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative